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# DIODES, POWER RECTIFIER, SCHOTTKY BARRIER

# **BASED ON TYPE STPS40100**

ESCC Detail Specification No. 5106/019

| Ī   | Issue 5 | July 2014 |
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|---------|--|
| 868     | Specification upissued to incorporate editorial changes per DCR. |

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#### 1 **GENERAL**

#### 1.1 SCOPE

This specification details the ratings, physical and electrical characteristics and test and inspection data for the component type variants and/or the range of components specified below. It supplements the requirements of, and shall be read in conjunction with, the ESCC Generic Specification listed under Applicable Documents.

#### 1.2 APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:

- (a) ESCC Generic Specification No. 5000
- (b) MIL-STD-750, Test Methods and Procedures for Semiconductor Devices

#### 1.3 TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. 21300 shall apply.

#### 1.4 THE ESCC COMPONENT NUMBER AND COMPONENT TYPE VARIANTS

#### 1.4.1 The ESCC Component Number

The ESCC Component Number shall be constituted as follows:

Example: 510601901

Detail Specification Reference: 5106019

Component Type Variant Number: 01 (as required)

#### 1.4.2 Component Type Variants

The component type variants applicable to this specification are as follows:

| Variant<br>Number | Based on Type | Case   | Common<br>Cathode<br>Terminal | Lead/Terminal<br>Material and Finish | Weight<br>max g |
|-------------------|---------------|--------|-------------------------------|--------------------------------------|-----------------|
| 01                | STPS40100     | TO-254 | 2                             | H9                                   | 10              |
| 02                | STPS40100     | TO-254 | 1                             | H9                                   | 10              |
| 03                | STPS40100     | SMD1   | 3                             | Q14                                  | 3               |

The lead/terminal material and finish shall be in accordance with the requirements of ESCC Basic Specification No. 23500.

#### 1.5 MAXIMUM RATINGS

The maximum ratings shall not be exceeded at any time during use or storage.

Maximum ratings shall only be exceeded during testing to the extent specified in this specification and when stipulated in Test Methods and Procedures of the ESCC Generic Specification.

Maximum Ratings

300

100

1

20

40

30

-65 to +175

+175

-65 to +175

+260

+245

10000

1.5

1.2

1.3

0.9

 $^{\circ}\text{C/W}$ 

Symbols

 $I_{FSM}$ 

 $V_{RRM}$ 

 $I_{RRM}$ 

 $I_0$ 

I<sub>F(rms)</sub>

 $\mathsf{T}_{\mathsf{op}}$ 

 $T_i$ 

 $T_{stg}$ 

 $\mathsf{T}_{\mathsf{sol}}$ 

dV/dt

 $R_{th(j-c)}$ 



Characteristics

Forward Surge Current (per Diode)

Repetitive Peak Reverse Voltage

Repetitive Peak Reverse Current

Average Output Rectified Current

Variants 01, 02 and 03 (per Diode)

Variants 01, 02 and 03 (per Device)

RMS Forward Current per Diode

**Operating Temperature Range** 

Storage Temperature Range

Critical Rate of Rise of Reverse

Thermal Resistance, Junction to

Variants 01 and 02 (per Diode)

Variants 01 and 02 (per Device)

Variant 03 (per Diode)

Variant 03 (per Device)

(Case Temperature)

Junction Temperature

Soldering Temperature

For TO-254

For SMD1

Voltage

Case

**ISSUE 5** Unit Remarks Α Note 1 V Note 2 Α Note 3 Α 50% Duty Cycle Notes 4, 9 Α οС Note 5 οС οС Note 5 οС Note 6 Note 7 V/µs

Notes 8, 9

#### NOTES:

- Sinusoidal pulse of 10ms duration.
- 2. Pulsed, duration 5ms, f = 50Hz.
- 3. Pulsed, duration  $2\mu s$ , f = 1kHz.
- 4. For Variants 01 and 02 at  $T_{case} \ge +132$  °C per Device and  $T_{case} \ge +148$  °C per Diode, derate linearly to 0A at +175 °C. For Variant 03 at  $T_{case} \ge +143$  °C per Device and  $T_{case} \ge +152$  °C per Diode, derate linearly to 0A at +175 °C.
- 5. For Variants with hot solder dip lead finish all testing performed at  $T_{amb} > +125$  °C shall be carried out in a 100% inert atmosphere.
- 6. Duration 10 seconds maximum at a distance of not less than 1.5mm from the device body and the same lead shall not be resoldered until 3 minutes have elapsed.
- 7. Duration 5 seconds maximum and the same package shall not be resoldered until 3 minutes have elapsed.
- 8. Package mounted on infinite heatsink.
- 9. The "per Device" ratings apply only when both anode terminals are tied together.



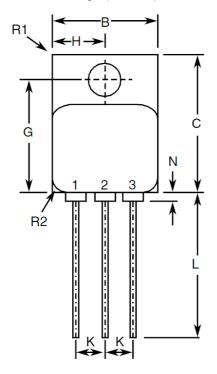
# 1.6 <u>HANDLING PRECAUTIONS</u>

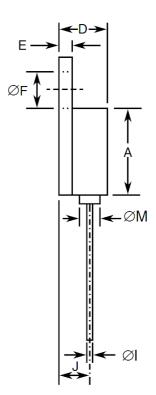
The TO-254 package contains Beryllium Oxide (BeO) and therefore it must not be ground, machined, sandblasted or subjected to any mechanical operation which will produce dust. The case must not be subjected to any chemical process (e.g. etching) which will produce fumes.

# 1.7 PHYSICAL DIMENSIONS AND TERMINAL IDENTIFICATION

Consolidated Notes are given following the case drawings and dimensions.

# 1.7.1 Metal Flange Mount Package (TO-254) - 3 Lead



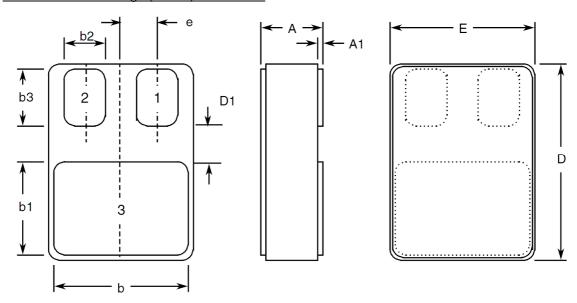


| 0       | Dimensi     | Nictor |       |
|---------|-------------|--------|-------|
| Symbols | Min         | Max    | Notes |
| Α       | 13.59       | 13.84  |       |
| В       | 13.59       | 13.84  |       |
| С       | 20.07 20.32 |        |       |
| D       | 6.3         | 6.7    |       |
| E       | 1           | 1.35   |       |
| ØF      | 3.5         | 3.9    |       |
| G       | 16.89       | 17.4   |       |
| Н       | 6.86 BSC    |        |       |
| ØI      | 0.89        | 1.14   | 2     |



| Comple a la | Dimensi      | Notes |       |
|-------------|--------------|-------|-------|
| Symbols     | Min          | Max   | Notes |
| J           | 3.81         |       |       |
| K           | 3.81         |       |       |
| L           | 12.95        | 14.5  |       |
| ØM          | 3.05 T       | 2     |       |
| N           | - 0.71       |       | 2     |
| R1          | - 1          |       | 3, 4  |
| R2          | 1.65 Typical |       | 3, 4  |

# 1.7.2 Surface Mount Package (SMD1) - 3 terminal



| Cumhala | Dimensi | Notes |       |
|---------|---------|-------|-------|
| Symbols | Min     | Max   | Notes |
| А       | 3.3     | 3.61  |       |
| A1      | 0.25    | 0.51  |       |
| b       | 9.4     | 9.65  |       |
| b1      | 10.41   | 10.67 |       |
| b2      | 3.43    | 3.68  | 4     |
| b3      | 3.86    | 4.11  | 4     |
| D       | 15.75   | 16    |       |
| D1      | 0.76    | -     | 4     |



| C. mahada | Dimensi | Natas |       |
|-----------|---------|-------|-------|
| Symbols   | Min     | Max   | Notes |
| E         | 11.3    | 11.56 |       |
| е         | 2.67    | 4     |       |

# 1.7.3 <u>Notes to Physical Dimensions and Terminal Identification</u>

- 1. The terminal identification is specified by the component's geometry. See Functional Diagram for the terminal connections.
- 2. 3 places.
- 3. Radius
- 4. 2 places.

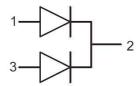
# 1.8 <u>FUNCTIONAL DIAGRAM</u>

Variant 01

Terminal 1: Anode a

Terminal 2: Common Cathode

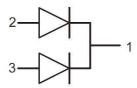
Terminal 3: Anode b



Variant 02

Terminal 1: Common Cathode

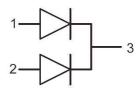
Terminal 2: Anode a Terminal 3: Anode b



Variant 03

Terminal 1: Anode a Terminal 2: Anode b

Terminal 3: Common Cathode



#### **NOTES:**

- 1. For TO-254, the case is not connected to any lead.
- 2. For SMD1, the lid is not connected to any terminal.



#### 1.9 MATERIALS AND FINISHES

Materials and finishes shall be as follows:

#### (a) Case

For the metal flange mount package the case shall be hermetically sealed and have a metal body. The leads pass through ceramic eyelets brazed into the frame and the lid shall be welded.

For the surface mount package the case shall be hermetically sealed and have a ceramic body with a Kovar lid.

(b) Leads/Terminals

As specified in Component Type Variants.

#### 2 REQUIREMENTS

#### 2.1 GENERAL

The complete requirements for procurement of the components specified herein are as stated in this specification and the ESCC Generic Specification. Permitted deviations from the Generic Specification, applicable to this specification only, are listed below.

Permitted deviations from the Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirement and do not affect the component's reliability, are listed in the appendices attached to this specification.

#### 2.1.1 Deviations from the Generic Specification

#### 2.1.1.1 Deviation from Screening Tests - Chart F3

(a) High Temperature Reverse Bias Burn-in and the subsequent Final Measurements for HTRB shall be omitted.

#### 2.1.1.2 Deviations from Qualification and Periodic Tests - Chart F4

- (a) Constant Acceleration shall be omitted.
- (b) For SMD1, Terminal Strength is not applicable.

#### 2.2 MARKING

The marking shall be in accordance with the requirements of ESCC Basic Specification No. 21700 and as follows.

The information to be marked on the component shall be:

- (a) The ESCC qualified components symbol (for ESCC qualified components only).
- (b) The ESCC Component Number.
- (c) Traceability information.
- (d) Beryllium Oxide warning sign (TO-254 only).



# 2.3 TERMINAL STRENGTH

The test conditions for Terminal Strength, tested as specified in the ESCC Generic Specification, shall be as follows:

For TO-254, Test Condition: A, tension, with an applied force of 10N and a duration of 10s.

# 2.4 <u>ELECTRICAL MEASUREMENTS AT ROOM, HIGH AND LOW TEMPERATURES</u>

Electrical measurements shall be performed at room, high and low temperatures. Consolidated notes are given after the tables.

# 2.4.1 Room Temperature Electrical Measurements

The measurements shall be performed at  $T_{amb}$  = +22 ±3 °C.

| Characteristics      | Symbols MIL-STD-750                                       | Test Conditions | Limits  |  | Units |      |
|----------------------|---|-----------------|---|--|-------|------|
|                      |   | Test Method     | Note 1  | Min                                      | Max   |      |
| Reverse Current      | I <sub>R1</sub>   | 4016            | DC Method<br>V <sub>R</sub> = 100V  | -  | 30    | μА   |
|                      | I <sub>R2</sub>   | 4016            | DC Method<br>V <sub>R</sub> = 50V   | -  | 5     | μА   |
| Forward Voltage      | ward Voltage $V_{F1}$ 4011 Pulse Method $I_F = 5A$ Note 2 |                 | -   | 610                                      | mV    |      |
|                      | V <sub>F2</sub>   | 4011            | Pulse Method<br>I <sub>F</sub> = 10A<br>Note 2  | -  | 730   | mV   |
|                      | V <sub>F3</sub>   | 4011            | Pulse Method<br>I <sub>F</sub> = 20A<br>Note 2  | -  | 900   | mV   |
| Capacitance          | С   | 4001            | V <sub>R</sub> = 10Vdc<br>f = 1MHz  | -  | 1     | nF   |
| Thermal<br>Impedance | Z <sub>th(j-c)</sub>                                      | 3101            | $I_H$ = 15 to 40A<br>$t_H$ = 50ms<br>$I_M$ = 50mA<br>$t_{md}$ = 100 $\mu$ s<br>Note 3 | (Calculate ΔV <sub>F</sub> , see Note 4) |       | °C/W |



#### 2.4.2 High and Low Temperatures Electrical Measurements

| Characteristics | Symbols  | MIL-STD-750 | Test Conditions  | Limits |     | Units |
|-----------------|--|-------------|--|--------|-----|-------|
|                 |  | Test Method | Notes 1 and 5  | Min    | Max |       |
| Reverse Current | I <sub>R1</sub>  | 4016        | 4016 T <sub>case</sub> = +125 (+0 -5) °C<br>DC Method<br>V <sub>R</sub> = 100V |        | 20  | mA    |
|                 | I <sub>R2</sub>  | 4016        | $T_{case}$ = +125 (+0 -5) $^{\circ}$ C DC Method $V_{R}$ = 50V                 | -      | 7.5 | mA    |
| Forward Voltage | V <sub>F2</sub>  | 4011        | $T_{case}$ = +125 (+0 -5) °C<br>Pulse Method<br>$I_F$ = 10A<br>Note 2          | -      | 660 | mV    |
|                 | $V_{F3}$ 4011 $T_{case} = +125 (+0 -5)  ^{\circ}C$ Pulse Method $I_{F} = 20A$ Note 2 |             | -  | 850    | mV  |       |
|                 |  |             | $T_{case}$ = -55 (+5 -0) °C<br>Pulse Method<br>$I_F$ = 20A<br>Note 2           | -      | 950 | mV    |

# 2.4.3 <u>Notes to Electrical Measurement Tables</u>

- 1. Measurement per each diode.
- 2. Pulse Width ≤ 680µs, Duty Cycle ≤ 2%.
- 3. Performed only during Screening Tests Parameter Drift Values (Initial Measurements), go-no-go.
- 4. The limits for  $\Delta V_F$  shall be defined by the Manufacturer on every lot in accordance with MIL-STD-750 Method 3101 and shall guarantee the  $R_{th(j-c)}$  limits specified in Maximum Ratings.
- 5. Read and record measurements shall be performed on a sample of 5 components with 0 failures allowed. Alternatively a 100% inspection may be performed.

#### 2.5 PARAMETER DRIFT VALUES

Unless otherwise specified, the measurements shall be performed at  $T_{amb}$  = +22 ±3 °C.

The test methods and test conditions shall be as per the corresponding test defined in Room Temperature Electrical Measurements.

The drift values ( $\Delta$ ) shall not be exceeded for each characteristic specified. The corresponding absolute limit values for each characteristic shall not be exceeded.



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| Characteristics   | Symbols         |                       | Limits   | Units |    |
|-------------------|-----------------|-----------------------|----------|-------|----|
|                   |                 | Drift                 | Absolute |       |    |
|                   |                 | Value<br>Δ            | Min      | Max   |    |
| Reverse Current 1 | I <sub>R1</sub> | ±5<br>or (1)<br>±100% | -        | 30    | μΑ |
| Forward Voltage 1 | V <sub>F1</sub> | ±50                   | -        | 610   | mV |

#### **NOTES:**

1. Whichever is the greater referred to the initial value.

# 2.6 <u>INTERMEDIATE AND END-POINT ELECTRICAL MEASUREMENTS</u>

Unless otherwise specified, the measurements shall be performed at  $T_{amb}$  = +22 ±3 °C.

The test methods and test conditions shall be as per the corresponding test defined in Room Temperature Electrical Measurements.

The limit values for each characteristic shall not be exceeded.

| Characteristics | Symbols         | Limits |     | Units |
|-----------------|-----------------|--------|-----|-------|
|                 |                 | Min    | Max |       |
| Reverse Current | I <sub>R1</sub> | -      | 30  | μΑ    |
|                 | I <sub>R2</sub> | -      | 5   | μΑ    |
| Forward Voltage | $V_{F1}$        | -      | 610 | mV    |
|                 | V <sub>F2</sub> | -      | 730 | mV    |
|                 | V <sub>F3</sub> | -      | 900 | mV    |

# 2.7 POWER BURN-IN CONDITIONS

| Characteristics  | Symbols           | Test Conditions | Units |
|------------------|-------------------|-----------------|-------|
| Case Temperature | T <sub>case</sub> | +125            | °C    |
| Reverse Voltage  | V <sub>R</sub>    | 80              | V     |

# 2.8 OPERATING LIFE CONDITIONS

The conditions shall be as specified for Power Burn-in.



# APPENDIX 'A' AGREED DEVIATIONS FOR STMICROELECTRONICS (F)

| ITEMS AFFECTED                                      | DESCRIPTION OF DEVIATIONS   |
|---|---|
| Deviations from<br>Production Control -<br>Chart F2 | Special In-Process Controls - Internal Visual Inspection. Wedge bonds equal to 1.1 wire diameter are acceptable for bonding with a V-Groove tool. |
| Deviations from<br>Screening Tests -<br>Chart F3    | Solderability is not applicable unless specifically stipulated in the Purchase Order.   |